

N-Channel Enhancement Mode MOSFET

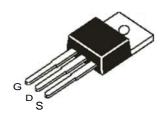
Features

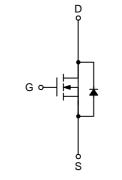
- · 70V/80A, $R_{DS(ON)} = 6m\Omega \text{ (typ.) @ V}_{GS} = 10V$
- · Avalanche Rated
- · Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

Applications

Power Management for Inverter Systems.

Pin Description





N-Channel MOSFET

Ordering and Marking Information



Package Code

P: TO220-3L Date Code

YYWW

Assembly Material G: Lead Free Device

Note: HOOYI lead-free products contain molding compounds/die attach materials and 100% matte tin plate termination finish; which are fully compliant with RoHS. HOOYI lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020D for MSL classification at lead-free peak reflow temperature. HOOYI defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HOOYI reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
Common F	Ratings (T _A =25°C Unless Otherwise Noted)			
V _{DSS}	Drain-Source Voltage		70	V
V _{GSS}	Gate-Source Voltage		±25	
TJ	Maximum Junction Temperature		175	°C
T _{STG}	Storage Temperature Range		-55 to 175	°C
Is	Diode Continuous Forward Current	80	А	
Mounted o	on Large Heat Sink	•	•	
I _{DM}	300µs Pulse Drain Current Tested	T _C =25°C	320*	А
	T _C =25°C		80	- A
l _D	Continuous Drain Current	Continuous Drain Current T _C =100°C		
В	T _C =25°C		180	10/
P_{D}	Maximum Power Dissipation	75	→ W	
$R_{\theta JC}$	Thermal Resistance-Junction to Case	1.2	°C/W	
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	62.5	°C/W	
E _{AS}	Drain-Source Avalanche Energy	650	mJ	

Note: *Pulse width limited by safe operating area.

Electrical Characteristics (T_A = 25°C Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	HY1707P			Unit
Symbol	Farameter	rest Conditions	Min.	Тур.	Max.	Onne
Static Ch	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250μA	70	74	-	V
	Zero Gate Voltage Drain Current	V _{DS} =70V, V _{GS} =0V	-	-	1	
I _{DSS}	Zero Gate Voltage Drain Current	T _J =85°C	-	-	10	μΑ
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{DS}=250\mu A$	2	3	4	V
I _{GSS}	Gate Leakage Current	$V_{GS}=\pm 25V$, $V_{DS}=0V$	ı	1	±100	nΑ
R _{DS(ON)} a	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =40A	ı	6	7	mΩ
Diode Ch	Diode Characteristics					
V _{SD} ^a	Diode Forward Voltage	I _{SD} =40A, V _{GS} =0V	-	0.8	1	V
t _{rr}	Reverse Recovery Time	1 404 dl /dt 1004/vo	-	55	-	ns
Q _{rr}	Reverse Recovery Charge	I _{DS} =40A, dI _{SD} /dt=100A/μs	-	100	-	nC



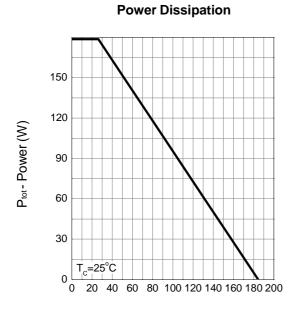
Electrical Characteristics (Cont.) $(T_A = 25^{\circ}C \text{ Unless Otherwise Noted})$

Symbol	Parameter	Test Conditions	HY1707P			Unit	
Symbol	raidilletei Test Collutions		Min.	Тур.	Max.	Offic	
Dynamic	Characteristics ^b						
R_{G}	Gate Resistance	V_{GS} =0V, V_{DS} =0V, F =1MHz	-	0.9	-	Ω	
C _{iss}	Input Capacitance	V _{GS} =0V,	-	2140	-		
C _{oss}	Output Capacitance	V _{DS} =30V,	-	270	-	pF	
C _{rss}	Reverse Transfer Capacitance	Frequency=1.0MHz	-	150	-		
t _{d(ON)}	Turn-on Delay Time	V_{DD} =30V, R_L =30 Ω , I_{DS} =1A, V_{GEN} =10V, I_{GG} =6 Ω	-	21	39		
T _r	Turn-on Rise Time		-	10	19	ns	
$t_{\text{d(OFF)}}$	Turn-off Delay Time		-	58	105	113	
T_f	Turn-off Fall Time		-	31	57		
Gate Charge Characteristics ^b							
Q_g	Total Gate Charge	V _{DS} =30V, V _{GS} =10V, I _{DS} =40A	-	40	64		
Q _{gs}	Gate-Source Charge		-	12	-	nC	
Q_{gd}	Gate-Drain Charge			19	-		

Note a : Pulse test ; pulse width \leq 300 μ s, duty cycle \leq 2%. Note b : Guaranteed by design, not subject to production testing.

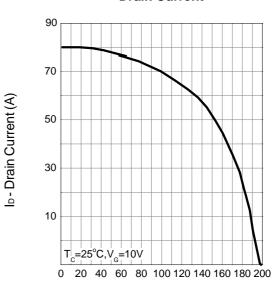


Typical Operating Characteristics



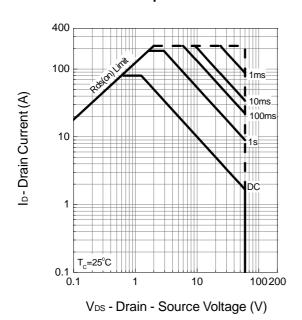
T_j- Junction Temperature (°C)

Drain Current

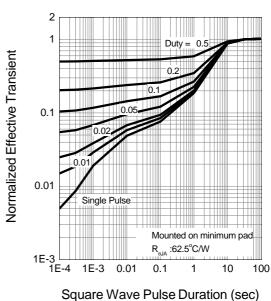


T_j - Junction Temperature (°C)

Safe Operation Area



Thermal Transient Impedance

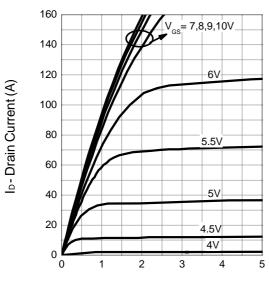


oquare wave Fulse Duration (sec)



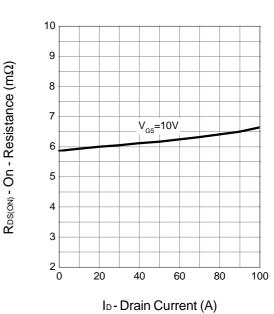
Typical Operating Characteristics (Cont.)

Output Characteristics

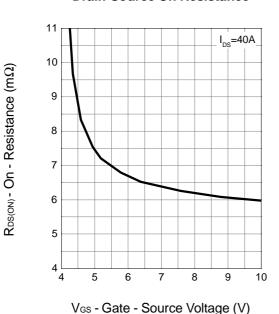


V_{DS} - Drain-Source Voltage (V)

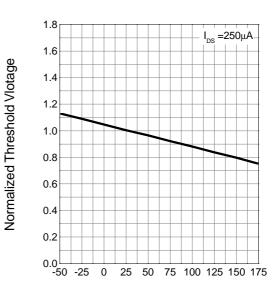
Drain-Source On Resistance



Drain-Source On Resistance



Gate Threshold Voltage

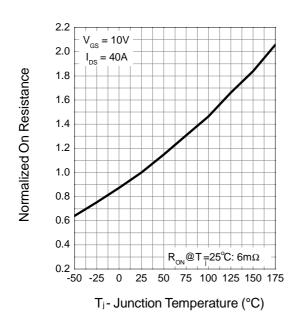


T_j - Junction Temperature (°C)

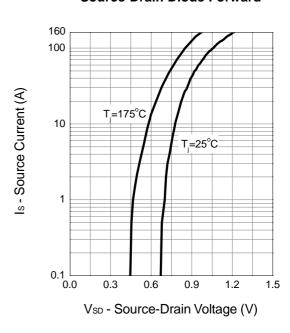


Typical Operating Characteristics (Cont.)

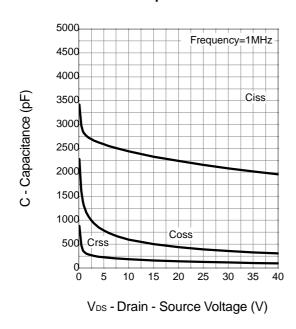
Drain-Source On Resistance



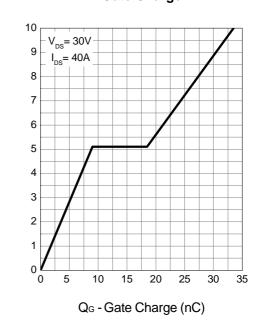
Source-Drain Diode Forward



Capacitance



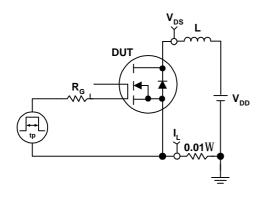
Gate Charge

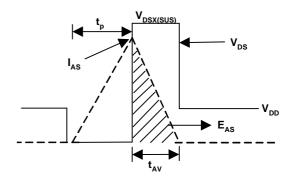


Ves - Gate-source Voltage (V)

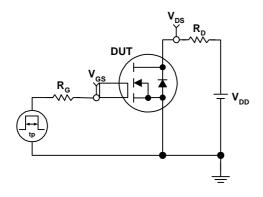


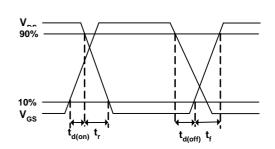
Avalanche Test Circuit and Waveforms





Switching Time Test Circuit and Waveforms

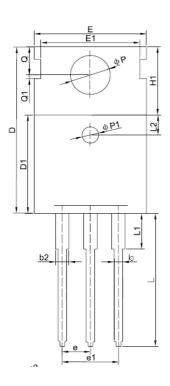


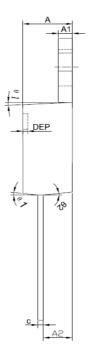




Package Information

TO-220







COMMON DIMENSIONS

SYMBOL	м	ILLIMET	ER		INCHE	S
SIMBUL	MIN	NDM	MAX	MIN	NDM	MAX
Α	4.40	4.57	4.70	0.173	0.180	0.185
A1	1.27	1.30	1.33	0.050	0.051	0.052
A2	2.59	2.69	2.79	0.102	0.106	0.110
b	0.77	-	0.90	0.030	-	0.035
b2	1.23	_	1.36	0.048	-	0.054
C	0.48	0.50	0.52	0.019	0.020	0.021
D	15.10	15.40	15.70	0.594	0.606	0.618
D1	9.00	9.10	9.20	0.354	0.358	0.362
DEP	0.05	0.10	0.20	0.002	0.004	0.008
E	10.06	10.16	10.26	0.396	0.400	0.404
E1	-	8.70	-	-	0.343	-
Фр1	1.40	1.50	1.60	0.055	0.059	0.063
е		2.54BS			0.1BSC	
e1		5.08BS	3		0.2BSC	
H1	6.10	6.30	6.50	0.240	0.248	0.256
L	12.75	-	13.17	0.502	-	0.519
L1	-	-	3.95	-	-	0.156
L2		1.85REF		0.073REF		
Фр	3.57	3.60	3.63	0.141	0.142	0.143
Q	2.73	2.80	2.87	0.107	0.110	0.113
Q1	-	0.20	-	-	0.008	-
θ1	5°	7°	9°	5°	7°	9°
0 2	1°	3°	5°	1°	3°	5°

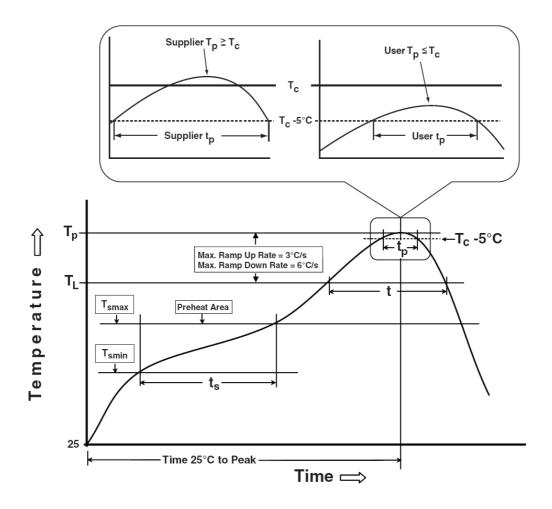
NOTES: 1.ALL DIMENSIONS REFER TO JEDEC STANDARD TO220 -3L DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS



Devices Per Unit

Package Type	Unit	Quantity	
TO-220	Tube	50	

Classification Profile





Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly		
$ \begin{array}{c} \textbf{Preheat \& Soak} \\ \textbf{Temperature min } (\textbf{T}_{smin}) \\ \textbf{Temperature max } (\textbf{T}_{smax}) \\ \textbf{Time } (\textbf{T}_{smin} \text{ to } \textbf{T}_{smax}) \ (\textbf{t}_{s}) \end{array} $	100 °C 150 °C 60-120 seconds	150 °C 200 °C 60-120 seconds		
Average ramp-up rate (T _{smax} to T _P)	3 °C/second max.	3°C/second max.		
Liquidous temperature (T_L) Time at liquidous (t_L)	183 °C 60-150 seconds	217 °C 60-150 seconds		
Peak package body Temperature $(T_p)^*$	See Classification Temp in table 1	See Classification Temp in table 2		
Time (t _P)** within 5°C of the specified classification temperature (T _c)	20** seconds	30** seconds		
Average ramp-down rate (T _p to T _{smax})	6 °C/second max.	6 °C/second max.		
Time 25°C to peak temperature	6 minutes max.	8 minutes max.		
* Tolerance for peak profile Temperature (T _p) is defined as a supplier minimum and a user maximum. ** Tolerance for time at peak profile temperature (t _p) is defined as a supplier minimum and a user maximum.				

Table 1. SnPb Eutectic Process – Classification Temperatures (Tc)

Package Thickness	Volume mm ³ <350	Volume mm³ ³350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2. Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm ³	Volume mm ³	Volume mm ³
Thickness	<350	350-2000	>2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HOLT	JESD-22, A108	1000 Hrs, Bias @ 125°C
PCT	JESD-22, A102	168 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -65°C~150°C